

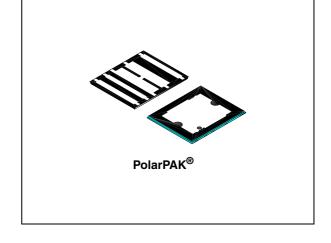
STK800

N-channel 30V - 0.006Ω - 20A - PolarPAK[®] STripFET™ Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)}	R _{DS(on)} *Q _g	P _{TOT}
STK800	30V	<0.0078Ω	100.5nC*mΩ	5.2W

- Ultra low top and bottom junction to case thermal resistance
- Very low capacitances
- 100% Rg tested
- Fully encapsulated die
- 100% Matte tin finish (in compliance with the 2002/95/EC european directive)
- PolarPAK® is a trademark of VISHAY



Application

Switching applications

Description

This Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low onresistance, moreover the double sides cooling package with ultra low junction to case thermal resistance allows to handle higher levels of current.

Figure 1. Internal schematic diagram

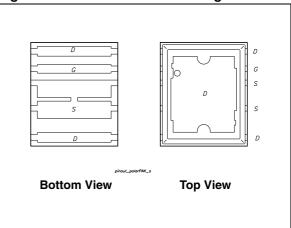


Table 1. Device summary

Order code	Marking	Package	Packaging	
STK800	K800	PolarPAK [®]	Tape & reel	

Contents STK800

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STK800 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{GS} ⁽¹⁾	Gate-source voltage	± 16	V
V _{GS} ⁽²⁾	Gate-source voltage	± 18	V
I _D ⁽⁴⁾	Drain current (continuous) at T _C = 25°C	20	Α
I _D	Drain current (continuous) at T _C = 100°C	12.5	Α
I _{DM} ⁽³⁾	Drain current (pulsed)	80	Α
P _{TOT} ⁽⁴⁾	Total dissipation at T _C = 25°C	5.2	W
	Derating factor	0.0416	W/°C
E _{AS} ⁽⁵⁾	Single pulse avalanche energy	1	J
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

- 1. Continuous mode
- 2. Guaranteed for test time ≤15ms
- 3. Pulse width limited by package
- 4. When mounted on FR-4 board of 1inch², 2 oz Cu and ≤10sec
- 5. Starting $T_J = 25^{\circ}C$, $I_D = 10A$, $V_{DD} = 25V$

Table 3. Thermal data

Symbol	Parameter	Тур.	Max.	Unit
Rthj-amb ⁽¹⁾	Thermal resistance junction-amb	20	24	°C/W
Rthj-c ⁽²⁾	Thermal resistance junction-case (top drain)	1	1.2	°C/W
Rthj-c ⁽³⁾	Thermal resistance junction-case (source)	2.8	3.4	°C/W

- 1. When mounted on FR-4 board of 1inch², 2 oz Cu and ≤10sec
- 2. Steady state
- 3. Measured at source pin when the device is mounted on FR-4 board in steady state

Electrical characteristics STK800

2 Electrical characteristics

(T_{CASE} =25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250\mu A, V_{GS} = 0$				V
I _{DSS}	Zero gate voltage drain $V_{DS} = Max rating,$ $V_{DS} = Max rating$				1 10	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±16V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$			2.5	V
R _{DS(on)}	Static drain-source on resistance	V_{GS} = 10V, I_{D} = 10A V_{GS} = 4.5V, I_{D} = 10A		0.006 0.0075	0.0078 0.0098	Ω Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		1380 450 75		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =15V, I_{D} = 20A V_{GS} =4.5V (see Figure 16)		13.4 3.4 4.5		nC nC nC
Q _{gs1}	Pre V _{th} gate-to-source charge Post V _{th} gate-to-source charge	V_{DD} =15V, I_{D} = 12A V_{GS} =4.5V (see Figure 21)		1 2.4		nC nC
R_{G}	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20mV open drain		1		Ω

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	V_{DD} = 15V, I_{D} = 10A, R_{G} =4.7 Ω , V_{GS} =4.5V (see Figure 15)		15 50		ns ns
t _{d(off)}	Turn-off delay time Fall time	V_{DD} =15V, I_{D} = 10A, R_{G} =4.7 Ω , V_{GS} =4.5V (see Figure 15)		45 15		ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)				20 80	A A
V _{SD} ⁽²⁾	Forward on Voltage	I _{SD} = 20A, V _{GS} =0			1.2	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 20A, di/dt = 100A/µs, V_{DD} =20V, Tj=150°C (see Figure 20)		32 28.8 1.8		ns nC A

^{1.} Pulse width limited by package

^{2.} Pulsed: pulse duration = $300\mu s$, duty cycle 1.5%

Electrical characteristics STK800

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

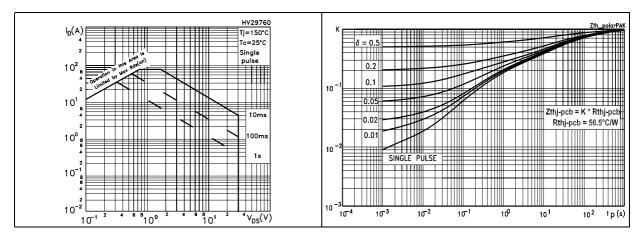


Figure 4. Output characteristics

Figure 5. Transfer characteristics

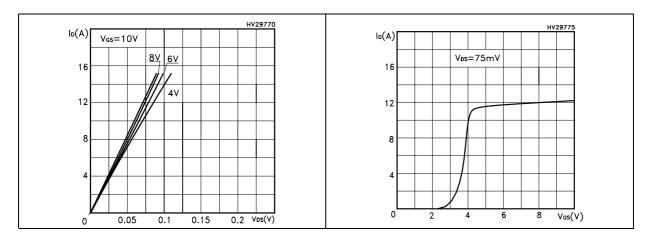


Figure 6. Transconductance

Figure 7. Static drain-source on resistance

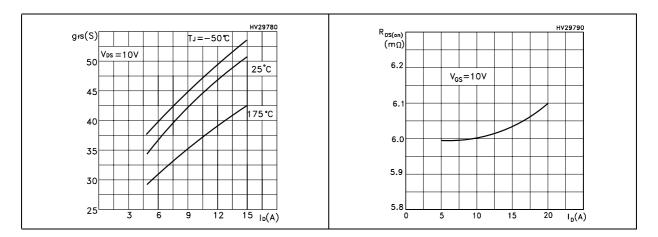


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

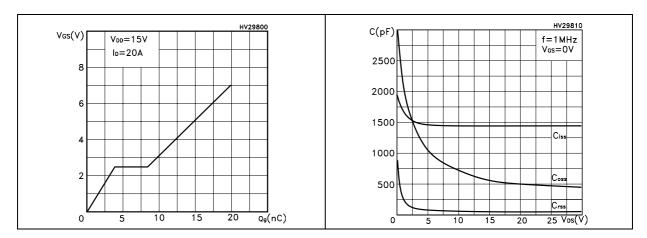


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on resistance vs temperature

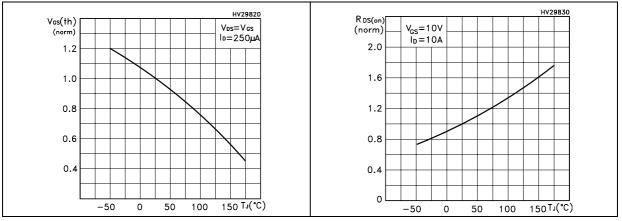
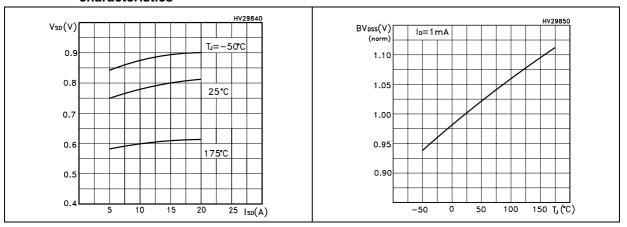


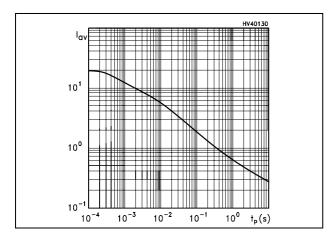
Figure 12. Source-drain diode forward characteristics

Figure 13. Normalized B_{VDSS} vs temperature



Electrical characteristics STK800

Figure 14. Allowable I_{AV} vs time in avalanche



The previous curve gives the single pulse safe operating area for unclamped inductive loads, under the following conditions:

$$P_{D(AVE)} = 0.5*(1.3*B_{VDSS}*I_{AV})$$

$$E_{AS(AR)} = P_{D(AVE)} *t_{AV}$$

Where:

I_{AV} is the allowable current in avalanche

 $P_{D(AVE)}$ is the average power dissipation in avalanche (single pulse)

 t_{AV} is the time in avalanche

STK800 Test circuit

3 Test circuit

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

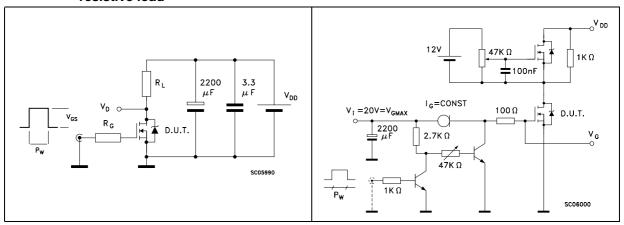


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

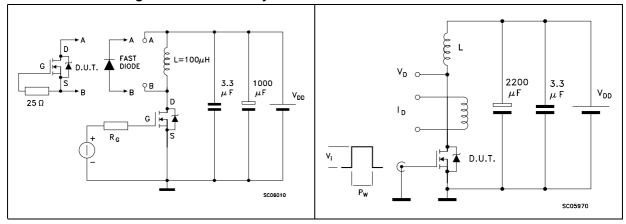
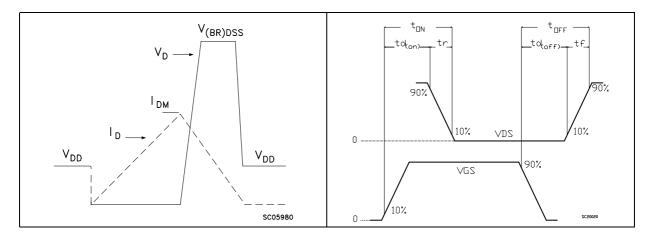


Figure 19. Unclamped inductive waveform

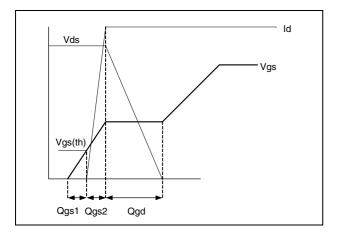
Figure 20. Switching time waveform



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Test circuit STK800

Figure 21. Gate charge waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

Table 8. PolarPAK® (option "S") mechanical data

iable o.	T Oldit Alt	(option o	inechanica	Tuata				
Ref.		mm			inch			
nei.	Min.	Тур.	Max.	Min.	Тур.	Max.		
Α	0.75	0.80	0.85	0.030	0.031	0.033		
A1			0.05			0.002		
b1	0.48	0.58	0.68	0.019	0.023	0.027		
b2	0.41	0.51	0.61	0.016	0.020	0.024		
b3	2.19	2.29	2.39	0.086	0.090	0.094		
b4	0.89	1.04	1.19	0.035	0.041	0.047		
b5	0.23	0.33	0.43	0.009	0.013	0.017		
С	0.20	0.25	0.30	0.008	0.010	0.012		
D	6	6.15	6.30	0.236	0.242	0.248		
D1	5.74	5.89	6.04	0.226	0.232	0.238		
Е	5.01	5.16	5.31	0.197	0.203	0.209		
E1	4.75	4.90	5.05	0.187	0.193	0.199		
H1	0.23			0.009				
H2	0.45		0.56	0.018		0.022		
НЗ	0.31	0.41	0.51	0.012	0.016	0.020		
H4	0.45		0.56	0.018		0.022		
11	1.92	1.97	2.02	0.075	0.077	0.079		
J1	0.38	0.43	0.48	0.014	0.016	0.018		
K1	4.22	4.37	4.52	0.166	0.172	0.178		
K4	0.24			0.009				
M1	4.30	4.50	4.70	0.169	0.177	0.185		
M2	3.43	3.58	3.73	0.135	0.141	0.147		
МЗ	0.22			0.009				
M4	0.05			0.002				
P1	0.15	0.20	0.25	0.006	0.008	0.010		
T1	3.48	3.64	4.10	0.137	0.143	0.161		
T2	0.56	0.76	0.95	0.022	0.030	0.037		
ТЗ	1.20			0.047				
T4	3.90			0.154				
T5		0.18	0.36		0.007	0.014		
<	0°	10°	12°	0°	10°	12°		
		1	1	1	T.	1		

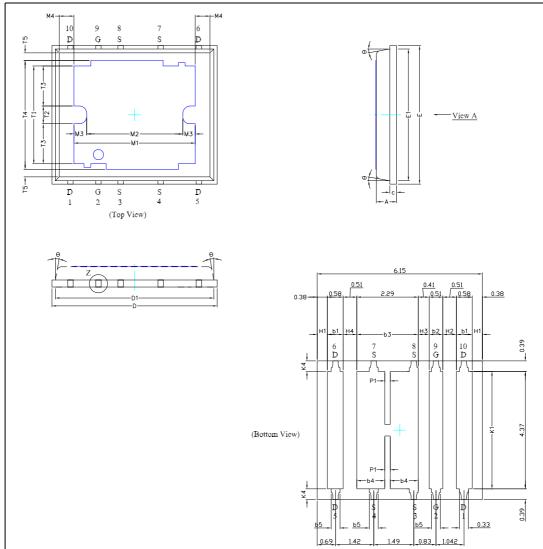


Figure 22. PolarPAK® (option "S") drawings

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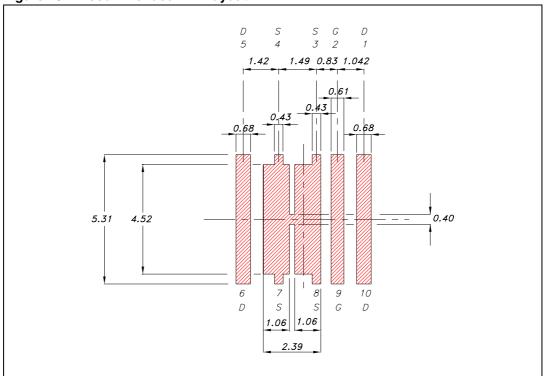


Figure 23. Recommended PAD layout

STK800 Revision history

5 Revision history

Table 9. Document revision history

Date	Revision	Changes
10-Nov-2005	1	First version
02-Feb-2006	2	Complete version
21-Mar-2006	3	The document has been reformatted
25-May-2006	4	New note on page 1
14-Nov-2006	5	Modified : Features
14-May-2007	6	New data on Table 5 and new Figure 21
11-Jun-2007	7	Updated Figure 2, Figure 3
03-Sep-2007	8	Updated mechancal data
05-Oct-2007	9	Inserted new Figure 23: Recommended PAD layout

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